FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. BO 42517 JGD SERIAL NO.

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

APPLICANT Edwin DE WINTER et al.

(Use several sheets if necessary) (37 CFR 1.98(b)				FILING DATE September 24, 20	01	GROUP	1761
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
94	AA	4,695,472	09-87	DUNN et al.			
	АВ	4,838,154	06-89	DUNN et al.		,	
	AC	5,235,905	08~93	BUSHNELL et al.			
	AD	5,447,733	09-95	BUSHNELL et al.			
	AE	5,514,391	05-96	BUSHNELL et al.			
	AF	5,549,041	08-96	ZHANG et al.		11	
	AG	5,690,978	11-97	YIN et al.			
	АН	5,776,529	07-98	QIN et al.			
g.y.	AI	6,027,754	02-00	BUSHNELL et al.			
FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION							
		DOCUMENT NO.	PUBL. DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB CLASS	TRANSLATION YES NO
gy	AJ	WO 96/38045	12-96	WIPO			YES
94	AK	WO 93/25097	12-93	WIPO			YES
	AL						
	AM	·			ļ		
	AN						<u> </u>
OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)							
9.4	AO	LUBICKI et al., XP-000546877, "INACTIVATION OF YERSINIA ENTEROCOLITICA GRAM-NEGATIVE BACTERIA USING HIGH VOLTAGE PULSE TECHNIQUE", Vol. 2, pps. 1338-1344, 10/95					
9.4	AP	QIN et al., XP-000766888, "INACTIVATING MICROORGANISMS USING A PULSED ELECTRIC FIELD CONTINUOUS TREATMENT SYSTEM", Vol. 34, pps. 43-49, 02-98					
EXAMI	NER	George Yeung DATE CONSIDERED Sept. 30, 2003					

EXAMINER: Initial citati n c nsidered. Draw line through citati n if not in conformance and not c nsidered. Include c py f this form with next c mmunication t applicant.